# MT8386M5

# N-Channel Enhancement Mode Field Effect Transistor

## **Product Summary**

- V<sub>DS</sub> = 30V
- I<sub>D</sub> = 150 A
- R DS(ON) =  $2.3 \text{m}\Omega$  @V<sub>GS</sub> = 10 V
- R DS(ON) =  $2.8 m \Omega @V_{GS} = 4.5 V$

#### **Features**

- · Advanced Trench Process Technology.
- · High Density Cell Design for Ultra Low On-Resistance.
- · Lead free product is acquired.
- · RoHS Compliant.
- PDFN5x6-8L Package

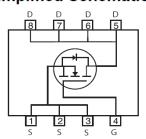
#### **Applications**

- · Power switching application
- · Hard switched and high frequency circuits
- · Uninterruptible power supply

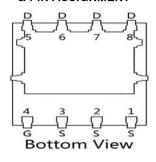
# MT Semiconductor®

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### Simplified Schematic



#### MARKING DIAGRAM & PIN ASSIGNMENT



# **Absolute Maximum Ratings** (T<sub>A</sub> = 25 ℃ unless otherwise noted)

Absolute Maximum Ratings T <sub>A</sub> =25℃ unless otherwise noted						
Parameter		Symbol	Maximum	Units		
Drain-Source Voltage		V <sub>DS</sub>	30	V		
Gate-Source Voltage		$V_{GS}$	±12	V		
Continuous Drain	T <sub>C</sub> =25℃		150			
Current <sup>G</sup>	T <sub>C</sub> =100℃	I <sub>D</sub>	95	A		
Pulsed Drain Current C		I <sub>DM</sub>	300			
Avalanche Current <sup>C</sup>		I <sub>AS</sub> , I <sub>AR</sub>	40	A		
Avalanche energy L=0.1mH <sup>C</sup>		E <sub>AS</sub> , E <sub>AR</sub>	80	mJ		
	T <sub>C</sub> =25℃	В	83	W		
Power Dissipation <sup>B</sup>	T <sub>C</sub> =100℃	— P <sub>D</sub>	33	VV		
	T <sub>A</sub> =25℃	В	2.5	10/		
Power Dissipation <sup>A</sup>	T <sub>A</sub> =70℃	P <sub>DSM</sub>	1.6	W		
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	С		

Thermal Characteristics						
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient <sup>A</sup>	t ≤ 10s	В	15	20	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	42	50	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	1.1	1.5	°C/W	

# **Thermal Characteristic**

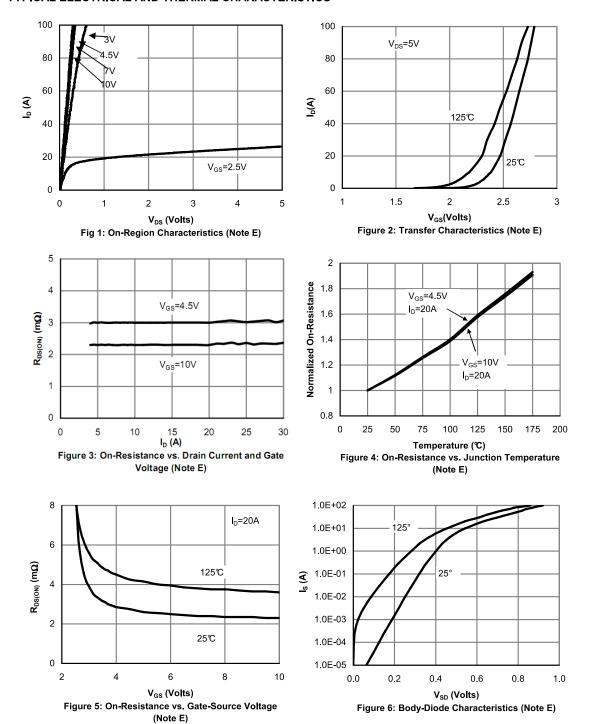
Thermal Resistance, Junction-to-Case	R <sub>0JC</sub>	1.15	°C/W
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# Electrical Characteristics (TJ=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC P	PARAMETERS						
$BV_{DSS}$	Drain-Source Breakdown Voltage	I <sub>D</sub> =10mA, V <sub>GS</sub> =0V		30			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V				0.5	mA
DSS	Zero Gate Voltage Drain Gurrent		T <sub>J</sub> =125℃			100	ША
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±12V				100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$		1.2	1.5	2	V
$I_{D(ON)}$	On state drain current	$V_{GS}$ =10V, $V_{DS}$ =5V		240			Α
	_	$V_{GS}$ =10V, $I_{D}$ =20A			2.3	2.8	mΩ
$R_{DS(ON)}$	Static Drain-Source On-Resistance		T <sub>J</sub> =125℃		2.5		11122
		$V_{GS}$ =4.5V, $I_D$ =20A			2.8	3.8	mΩ
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =20A			115		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V			0.4		V
Is	Maximum Body-Diode Continuous Current <sup>G</sup>					85	Α
DYNAMIC	C PARAMETERS <sup>b</sup>						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz			4830		pF
C <sub>oss</sub>	Output Capacitance				490		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				280		pF
$R_g$	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz		0.3	0.7	1.0	Ω
SWITCHI	NG PARAMETERS						
Q <sub>g</sub> (4.5V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =20A		24	31	38	nC
$Q_{gs}$	Gate Source Charge			8	11	14	nC
$Q_{gd}$	Gate Drain Charge			4	9	13	nC
$t_{D(on)}$	Turn-On DelayTime				10		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_L$ =0.75 $\Omega$ , $R_{GEN}$ =3 $\Omega$			6		ns
$t_{D(off)}$	Turn-Off DelayTime				50		ns
t <sub>f</sub>	Turn-Off Fall Time				7		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, dI/dt=500A/μ	s	9	12	15	ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =20A, dI/dt=500A/μ	s	17	22	27	nC

#### Note:

- a. Pulse test; pulse width  $\leq\!300\mu s,$  duty cycle  $\leq\!2\%.$
- b. Guaranteed by design, not subject to production testing.



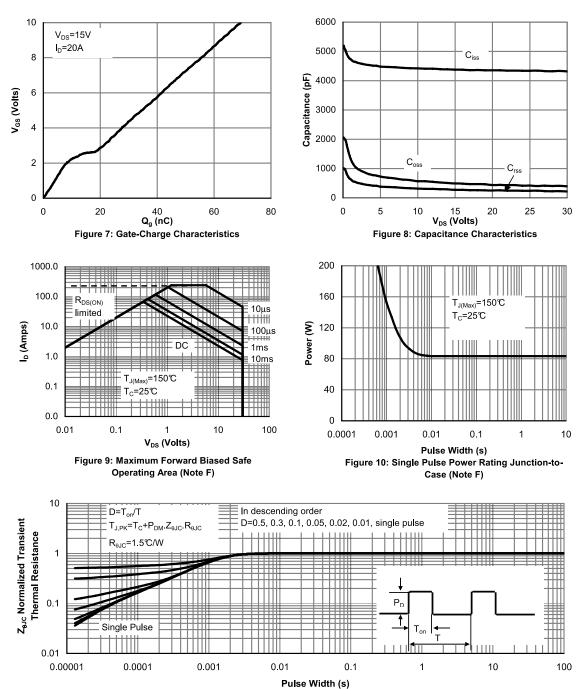


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

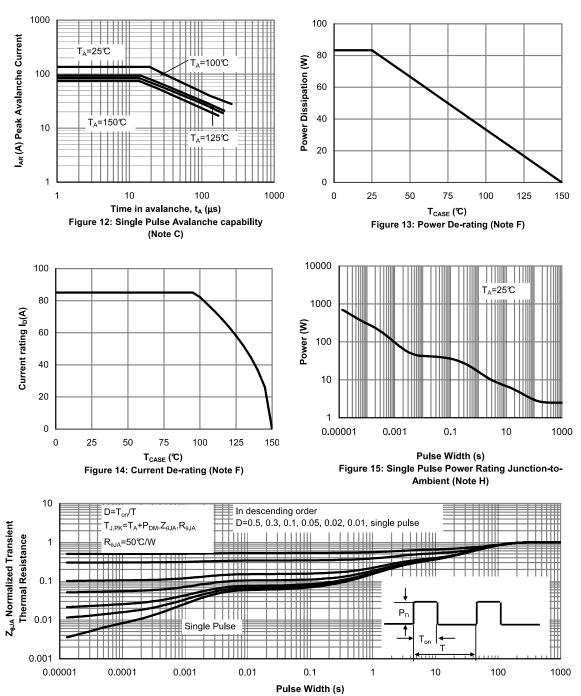
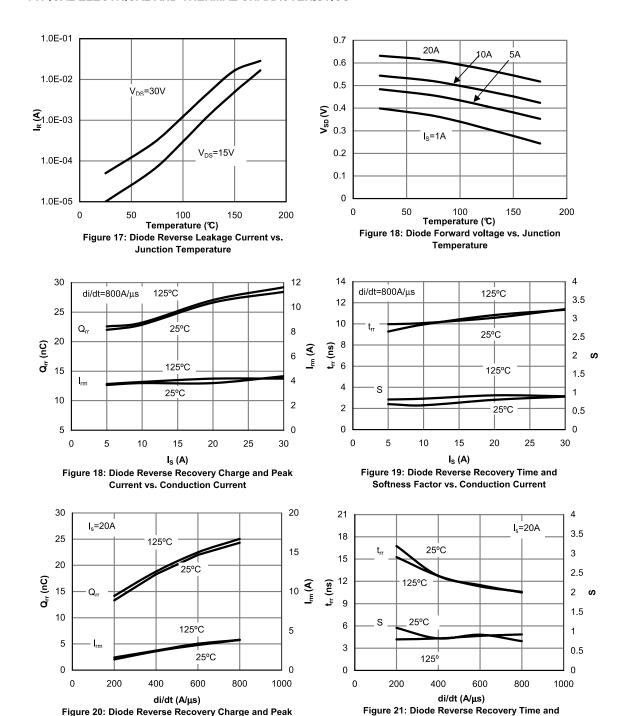


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Figure 20: Diode Reverse Recovery Charge and Peak

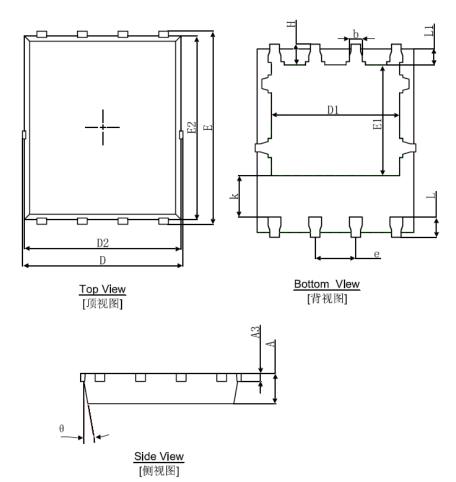
Current vs. di/dt



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Softness Factor vs. di/dt

# PDFN5X6-8L Package Information



Symbol	Dimensions	In Millimeters	Dimensions In Inches		
	Min.	Max.	Min.	Max.	
Α	0.900	1.000	0.035	0.039	
A3	0.254	REF.	0.010	REF.	
D	4.944	5.096	0.195	0.201	
E	5.974	6.126	0.235	0.241	
D1	3.910	4.110	0.154	0.162	
E1	3.375	3.575	0.133	0.141	
D2	4.824	4.976	0.190	0.196	
E2	5.674	5.826	0.223	0.229	
К	1.190	1.390	0.047	0.055	
b	0.035	0.450	0.014	0.018	
е	1.270	(TYP.)	0.050	(TYP.)	
L	0.559	0.711	0.022	0.028	
L1	0.424	0.576	0.017	0.023	
Н	0.574	0.726	0.023	0.029	
θ	8°	12°	8°	12°	

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